In Response to TDECQ/SECQ Questions for Threshold Adjustments and Proposed Changes

(Comments r01-98, r01-104, r01-99, r01-103, r01-102, r01-97)*

Frank Chang, Inphi; Pavel Zivny, Tektronix David Leyba, Keysight; Hai-Feng Liu, Intel Marco Mazzini, Cisco; Kohichi Tamura, Oclaro Mingshan Li, AOI; Mark Heimbuch, Source Winston Way, NeoPhotonics; Mark Kimber, Semtech Phil Sun, Credo Semiconductors

Special thanks to Ali Ghiasi for fruitful discussion on making the point that TDECQ value without threshold adjust may require module manufacturers to add additional guard banding during manufacturing (increase cost), but adjustable threshold receiver would require adjustable threshold SRS stressor.

*: With data to support comment resolutions for adding Adaptive Threshold Adjustments in computing TDECQ values (floating slicing)

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Update supporter list from Liu_3cd_01b_0118

Test instrument vendors

- Kan Tan (Tektronix)
- Greg LeCheminant (Keysight)
- Stephen Didde (Keysight)

Module/component vendors

- David Chen (AOI)
- Huanlin Zhang (AOI)
- David Lewis (Lumentum)
- David Li (Hisense)
- Mike Wang (Hisense)
- Scott Schube (Intel)
- Karen Liu (Kaiam)
- Alex Tselikov (Kaiam)
- Ed Ulrichs (Source Photonics)
- Zhigang Gong (O-Net)
- Adee Ran (Intel)
- Mizuki Shirao (Mitsubishi Electric Corp.)
- Mitsuo Akashi (Oclaro)
- Rang-Chen Yu (Molex)
- Shaoyun Yi (NeoPhotonics)
- Kent Lusted (Intel)
- Hideki Isono (Fujitsu Optical Components)
- John Mein (Dust Photonics)
 Inphi

ASIC/IC vendors

- Sudeep Bhoja (Inphi)
- Jeff Twombly (Credo)
- Atul Gupta (Macom)
- Matt Brown (Macom)
- Tom Palkert (Macom)
- Vasu Parthasarathy (Broadcom)
- Bharat Taylor (Semtech)
- Mike Li (Intel)
- Kevin Zhang (Integrated Device Technology)

Systems vendors/users

- David Piehler (Dell EMC)
- Samuel Liu (Nokia)
- Chongjin Xie (Alibaba)
- Zuowen Shen (Google)
- Earl Parsons (CommScope)
- Pirooz Tooyserkani (Cisco)
- Jane Lim (Cisco)
- Matt Traverso (Cisco)
- Tomoo Takahara (Fujitsu Lab)
- Tongqing Wang (Alpine Optoelectronics)
- Nathan Tracy (TE Connectivity)

Outline

Problem Statements

- □ To follow up discussion/questions from January interim
- Why threshold adjustment is necessary
 - Make the reference receiver close to real receiver by adding threshold adjustments
- Improved correlation between TDECQ and BER with threshold adjustment
 - Current correlation with D3.1 is considered arguably "poor".
- Small amounts of threshold adjustment have minimal impact on receiver sensitivity (SRS)
 - Using real ASICs under low power DSP to mode mimic reference 5T equalizers.



Problem Statements

- Strong support to add Adaptive Slicing in Ref. equalizers to resolve TDECQ specs dilemma (mazzini_120617_3cd_adhoc-v2)
 - Supported by 30+ companies including majority module and IC vendors as well as systems vendors/users.
 - Extensive data demonstrated some improvements (~0.3-0.4dB) across all transmitter types: DML, VCSEL, EML, and MZM.
 - Keysight and Tektronix have just released in mid Feb new beta FW with floating thresholds as defined in recent proposal. It includes setting an adjustable limit.
- Some questions asked "why threshold adj. is needed?" in real RX IC implementation a tutorial.
- □ No analog equalizers available with 5T for link BER measurements.
- □ Follow up questions from the editorial team (cite JonathanK)
 - Show improves correlation between TDECQ vs measured receiver sensitivity.
 - Show not too high a stress for the receiver in SRS tests



Why Threshold Adjustment is Necessary (1)

- The benefits of adaptive decision thresholds have been pointed out in many studies on CDRs & SerDes ICs for direct detect NRZ systems
 - Either manual or adaptive for optimized BER, refs. e.g.
 - 1) Matsumoto et al. "An adaptive decision threshold control of the optical receiver for multi-gigabit terrestrial DWDM transmission systems"; OFC 2001, Paper TuR2, March 2001. (2.5G NRZ)
 - 2) Park et al. "Performance Analysis for Optimizing Threshold Level Control of a Receiver in Asynchronous 2.5 Gbps/1.2 Gbps Optical Subscriber Network with Inverse Return to Zero(RZ) Coded Downstream and NRZ Upstream Re-modulation"; J. OSK V.13, No.3. pp361-366, Sept 2009. (2.5G/1.25G NRZ)
 - 3) Yan et al. "Performance enhancement in 10-Gb/s long-haul fiber links with adaptive eye mapping in an integrated Si-CMOS 16-bit transceiver IC"; IEEE Photonics Tech. Letters, Vol.17, No.8, pp1752-4, Aug. 2005. (10G NRZ)
 - 4) Chang et al; "Accurate in-situ monitoring of Q-factor and BER using adaptive sampling in a 10Gb/s CMOS optical receiver IC"; IMS05, Paper WEPL-3, June 2005. (10G NRZ)
- Adaptive decision thresholds have also been studied for coherent DSPs in QAM systems like QPSK & 16QAM for 100+G coherent DSP, refs. e.g.
 - 1) Chiba et al. "Adaptive threshold adjustment for signal distortion-free digital-coherent optical demodulation system"; Vol.16, No.26, Opt. Express, pp21647-55, Dec. 2008.



Why Threshold Adjustment is Necessary (2)

Results from unevenly distributed noise on 0/1 levels



Actually measured PAM4 histograms show similar



implementations, decision threshold level and phase of received data in the decision circuit are automatically adjusted to the optimum position



Why Threshold Adjustment is Necessary (3)

Threshold adjustment help improve implementing TDECQ

- With threshold adj, TDECQ is consistent across temperature so no guardband required in manufacturing (less test, higher yield, lower cost).
- D3.1 case: 0.3-0.4dB, guardband needed in manufacturing (increase test over temp, lower yield, and high cost)
 With threshold Adjustments



Correlate TDECQ with Rx Sensitivity

Under well controlled lab environments with golden EML TOSA, following 3 scenarios are considered for threshold adjustment within the limit of <2%

- (Setup refer to chang_011018_3cd_02_adhoc-v2 & chang_3cd_01a_0917)
- Full optimized EML condition, full link optimized with best BER condition.
 - Optimized EML Bias voltage, and Linear driver nonlinearity
- Off-optimized conditions,
 - Keep default EML bias voltage (VEML), vary Linear driver nonlinearity
- Unoptimized Case 1: Move two TX setting downwards;
 - Vary VEML bias down by ~ 150mV, and vary driver gain accordingly (all the rest no change)
- Unoptimized Case 2: move TX setting upwards;
 - Vary VEML bias up by ~ 150mV and vary driver gain accordingly (all the rest no change)





TX eye diagrams: optimized condition (D3.1)

Full optimized case (D3.1) ER=6.1dB TDECQ/SECQ=1.26dB, RLM=0.955



Note: TDECQ/SECQ tests for slides#9-12 are actually SECQ (without test fiber) and based on PRBS15 pattern.

TDECQ/SECQ=1.03dB Setup Measure Tools Apps Help Auto Scale Run Single Clear Waveform (F1) TDECQ Reference Equalizer Setup =dualized e Preset **v** + Custom Taps 🖌 Automatic Taps 🖌 Iterative Optimization 1Taps per UI **─** 5 ¥ 🔺 Number of Taps Jitter Tap Values. XХ Number of Taps: 5 Precursors: 1 OMA at Crossing X_aX Noise Processing VECP (⊗) ₽ Results Preserve Noise Measurement Current Count XX Input Noise Bandwidth: Average Power F1 888.8 µW Outer OMA F1 847.8 µW 🖌 Track Input Bandwidth 13.28 GHz F1 1.03 dB TDECQ More (1/4 Annotations 🗶 🛛 Details.. Limits. Setup..

Optimized case D3.1 with threshold Adj



TX eye diagrams: off-optimized condition (D3.1)

Off-optimized case (D3.1) ER=6.2dB TDECQ/SECQ=1.86dB, RLM=0.966



		Adj	%
Pth3	1130.167	-9.83333	-0.99%
Pavg	796	-1	-0.13%
Pth1	466.8333	-6.83333	-0.69%

Off-optimized case D3.1 with threshold Adj TDECQ/SECQ=1.35dB, Adj~1.% of OMAouter





TX eye diagrams: Case1 (D3.1)

Auto Single Clear

Processed eye

3 Level

Timebase Acquir 9.41 ps/ Full Patte + • ≡

Unoptimized Case1: ER=6.9dB TDECQ/SECQ=1.85dB, RLM =0.915

6 923 48

0.915

IA 1.2334

FI 0.915

Setup...

185/6

uter OMA

TDECO

Linearity (RLM)

Raw eye

Case1(D3.1 with threshold Adj) TDECQ/SECQ=1.42dB Adj within +1.95%



Annotations





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Add Eye Cortox

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TX eye diagrams: Case2 (D3.1)

Unoptimized case2 ER=5.6dB, TDECQ=2.56dB. RLM =0.926



		Adj	%
Pth3	877.3333	0.666667	0.09%
Pavg	629.4	-15.4	-1.93%
Pth1	381.4667	0.533333	0.07%



Auto Scale Run Single Clear

Case2 (D3.1 with threshold Adj) TDECQ=1.68dB, Adj within -1.93%

Eye/Mask		KEYSIGHT	File	Setup	Measure	Tools	Apps	Help	0	Auto Scale	Run Sing	e Clear		Waveform Memorie
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	Use	Measurement	t		Current		Count	Ť		🖌 Pre	serve Noise			
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Average Power		Outer OMA		F1	743.8 µW		1			🖌 Tra	ick Input Ban	dwidth 12.60 (GHz V	
		TDECQ		F1	1.68 dB		1							



Correlate TDECQ with Rx Sens: how to tackle the analog equalizer non-availability issue

Emulated low power DSP Mode with closer to Ref 5T equalizers for link BER measurements.



Comparing performance of various DSP modes (for BER flooring)





Correlate TDECQ with Rx Sensitivity







Note: 1:1 linear fit is a better approximation with threshold adjustment than the fixed threshold case which could be argued to be less than 1:1.

	Full optimized	off-optimized	Case1 <-2%	Case2 <+2%
EML bias	-1.28	-1.26	-1.41	-1.12
ER	6.1	6.2	6.9	5.6
TDECQ (D3.0)	1.26	1.86	1.85	2.56
TDECQ (TH adj	1.03	1.35	1.42	1.68
OMA Sens.	-14.5	-14.1	-14	-13.7

Show better correlation with TDECQ and predict well how RX sens. will vary when threshold adjustment is implemented with limits



Correlating TDECQ with Rx Sensitivity (D3.1)

- Some thoughts: All of us who took the data feel this correlation is "poor". Where is the "disconnection" with data analysis by king_3cd_01_0118?
 - The data analysis were good but based on statistics in macro scale with large fitting error of 0.3-0.4dB. If looking into individual TOSAs, there are many exceptions for the situation that good TDECQ values delivers worse RX Sens and vise verse, so simply tough to predict RX sensitivity from TDECQ values with D3.1, for examples: Good TDECQ, but

worse sens.



The Impact to RX SECQ (D3.1)

Recap current analysis with D3.1 by (<u>king_3cd_01_0118</u>)

 LN MZM TX for instrument testers are well behaved linear devices, and expect to show better correlation.



chang_3cd_01_1117 concluded that "There exists strong interplay between G.N and S.I (with S.J.). G.N. impact most the BER degradation in SRS.". But the data shows very good correlation between SECQ and Rx sensitivity for both GN and SI dominant stress (RMS error of <0.3 dB)



Impact to RX SRS (D3.1) by different DSP modes

Negligible impact on RX SRS Sensitivity by different DSP modes. (only little degrade on BER flooring) <u>chang_3cd_01_1117</u>

Compare Rx SRS under different DSP modes for no (B2B) and fully stressed

I M M7M TX

SSPRQ pattern





17

Impact to RX SRS (D3.1) by different DSP modes

Negligible impact on RX SRS Sensitivity by different DSP mode. (only little degrade on BER flooring) <u>chang 3cd 01 1117</u>

LM MZM TX SSPRQ pattern

Compare Rx SRS under different DSP modes for no (B2B) and fully stressed





The Impact to RX SECQ

Auto Scale Run Single Clear

Equalized eye

Level 3

D3.1 Full stressed, RX LPF~13.28GHz - SECQ=3.43dB, ER=3.6dB

Raw eye

3.43.48

3.638 dB

273.8 u/A

3.43 dB

3.638 dB

272.0 108



	uW	Adj (uW)	
Pth3	438	-3.5	-1.28%
Pavg	347	1	0.37%
Pth1	255	4	1.46%
OMAouter	273.8		

Annotations

(*) I





Waveform

inearity [RLM]

TDECO

Outer FR

Outer OM

F1 0.979

F1 3.43 dP

F1 3.638 dE

F1 273.8 uV

Add Eye Contour

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The Impact to RX SECQ

D3.1 over-stressed, RX LPF~13.28GHz SECQ=3.64dB, ER=3.5dB

File Setun Measure Tools Apps

/aveform



Equalized eye

Auto Run Single Clear

	uW	Adj (uW)	
Pth3	446	-2	-0.73%
Pavg	354	1	0.37%
Pth1	263	1.5	0.55%
OMAouter	274.7		





Local

The Impact to RX SRS Sensitivity

■ The impact on the Rx SRS is <0.2dB.

The real ASIC has threshold adjustment implemented.





Concluding Remarks (1)

- Adding threshold adjustment will minimize the need for guard banding and over temperature testing during manufacturing as well as aging, thus reduced test, higher yield and lower cost.
- Measured link BER with an emulate 5T equalizers by operating at low power DSP mode.
 - Eliminate the dilemma due to the non-availability of analog equalizers usable for such kinds of tests.
 - Threshold adjustment measurements show an improved correlation with receiver sensitivity (<0.1dBrms) and closer to 1:1 fit (as requested)
- The stress on RX SRS tests falls well within 0.1-0.2dB (or less). It seems much less than what we originally thought after setting the limits to the adjustable range.

💢 Inphi

Concluding Remarks (2)

Minimum risks to add threshold adjustment into TDECQ algorithm.

- Unless real receiver have threshold adjustment, the transmitter environmental variations and aging will result in TDECQ degradation requiring increased TDECQ guard banding in manufacturing (increased test, lower yield, higher cost).
- Real receivers will implement threshold adjustment to cope with temperature and aging variations. Using a small part of the adjustment range will allow for improved yield and lower cost.
- Real receivers optimize the decision thresholds, so the TDECQ reference receiver can also be allowed to optimize thresholds. If the adjustment range for each threshold is much smaller than that of real receivers, the receiver specifications can remain unchanged.
- This will make significant improvement over D3.1
 - Lower risk for compliance test in manufacturing.



Proposed Change: 138.8.5

Insert the text shown below in red to the list of exceptions

138.8.5 Transmitter and dispersion eye closure - quaternary (TDECQ)	17
	18
TDECQ is a measure of each optical transmitter's vertical eye closure as measured through an optical to	19
electrical converter (O/E) with a bandwidth equivalent to a combined reference receiver and worst case opti-	20
cal channel, and equalized with the reference equalizer specified in 138.8.5.1. Table 138-9 specifies the test	21
pattern to be used for measurement of TDECQ.	22
	23
TDECQ of each lane shall be within the limits given in Table 138-8 if measured using the methods speci-	24
fied in 121.8.5, with the following exceptions:	25
— The polarization rotator and test fiber shown in Figure 121–4 are not used	26
— The optical channel requirements in 121.8.5.2 do not apply	27
The optical channel requirements in 121.8.5.2 do not appry	28
— The combination of the O/E and the oscilloscope used to measure the optical waveform has a fourth-	29
order Bessel-Thomson filter response with a bandwidth of 11.2 GHz.	30
- The reference equalizer to be used for TDECQ for 50GBASE-SR, 100GBASE-SR2, and	31
200GBASE-SR4 is specified in 138.8.5.1.	32
P _{tb1} , P _{tb2} , and P _{tb3} may be varied by up to 2% of OMA _{outer} .	



Proposed Change: 139.7.5.3

Change the text as shown below in red.

139.7.5.3 TDECQ measurement method	44
	45
TDECO for 50GBASE-FR and 50GBASE-LR is measured as described in 121.8.5.3 with the exception that	46
the reference constituer is as specified in 139.7.5.4	47
and relation of equalizer is as specifica in reserver.	48

TDECQ for 50GBASE-FR and 50GBASE-LR is measured as described in 121.8.5.3 with the following exceptions:

- The reference equalizer is as specified in 139.7.5.4
- P_{th1}, P_{th2}, and P_{th3} may be varied by up to 2% of OMA_{outer}



Proposed Change: 140.7.5

Insert the text shown below in red to the list of exceptions

140.7.5 Transmitter and dispersion eye closure for PAM4 (TDECQ)			
	9		
The TDECQ shall be within the limits given in Table 140-6 if measured using the methods specified in	10		
121.8.5.1, 121.8.5.2, and 121.8.5.3 using a reference equalizer as described in 140.7.5.1, with the following	11		
exceptions:	12		
 The optical return loss of the transmitter compliance channel is 15.5 dB. 	13		
The signaling rate of the test pattern generator is as given in Table 140–6 and uses a test pattern spec-	14		
ified for TDECO in Table 140–10	15		
	16		
There are no interfering optical lanes and therefore the delay requirement of at least 31 UI between			
test pattern on one lane and any other lane, as specified in 121.8.5.1, is redundant.	18		
 The combination of the O/E converter and the oscilloscope has a fourth-order Bessel-Thomson filter 	19		
response with a bandwidth of approximately 26.5625 GHz.	20		
— The normalized noise power density spectrum, $N(f)$ in Equation (121–9), is equivalent to white noise	21		
filtered by a fourth-order Bessel-Thomson response filter with a bandwidth of 26.5625 GHz.	22		
P P and P may be varied by up to 2% of OMA	22		

--- P_{th1}, P_{th2}, and P_{th3} may be varied by up to 2% of OMA_{outer}.





Thank You

